## Notice of References Cited

Application/Control No. 09/819,131	Applicant(s)/Patent Under Reexamination OVADIA, SHLOMO		
Examiner	Art Unit		
Jade O. Laye	2614	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,574,796	06-2003	Roeck et al.	725/111
	В	US-2003/0002495	01-2003	Shahar et al.	370/389
	С	US-6,122,334	09-2000	Hughes, Robbin D.	375/350
	D	US-6,483,829	11-2002	Yamamoto, Katsuya	370/342
	Ε	US-6,804,262	10-2004	Vogel et al.	370/480
	F	US-6,510,162	01-2003	Fijolek et al.	370/432
	G	US-5,790,806	08-1998	Koperda, Francis Richard	709/252
	Н	US-6,678,893	01-2004	Jung, Choon-Jae	725/111
	1	US-			
	J	US-			
	К	US-			
	L	US-			
$\exists$	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	,		
	<b>V</b>			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.